## Application/Control No. Applicant(s)/Patent Under Reexamination 09/002,906 WUGOFSKI ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Hai Tran 2611 **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,737,029	04-1998	Ohkura et al.	725/56
	В	US-5,585,866	12-1996	Miller et al.	725/43
	С	US-5,635,989	06-1997	Rothmuller, Michael	725/46
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	I	US-			
	_	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
,	0					
	Р					
	Q					
	R					
	S					
	T					

## **NON-PATENT DOCUMENTS**

	TOTAL							
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	U							
	<b>V</b>							
	w							
	x							

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